

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/763,589	RHEE ET AL.		
Examiner	Art Unit		
Benny Q. Tieu	2614		

SEARCHER					
SEARCHED					
Class	Subclass	Date	Examiner		
379	67.1 88.13 88.18 88.22 68 70 77	11/17/2006	BQT		
	93.12-				
	93.18				
	201.01-				
	201.04				
	207.02				
	207.04				
	207.1				
	207.16				
			,		
,			-		

INTERFERENCE SEARCHED				
· Class	Subclass	Date	Examiner	
		<del></del>		
See Interfer	ext Search, ence Search stout	11/17/2006	BQT	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	11/17/2006	BQT		
Interference Search History Printout	11/17/2006	BQT		
·				